

1 Evaluation of Different Ni-Semiconductor Composites

2 as Electrodes for Enhanced Hydrogen Evolution

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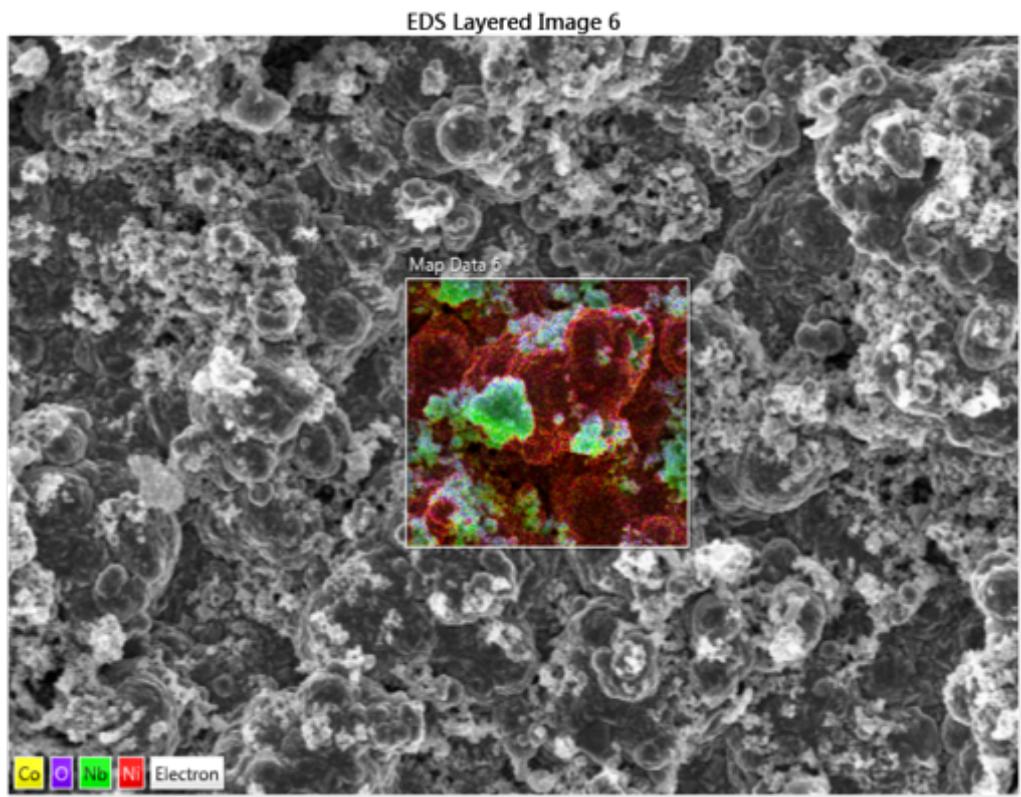
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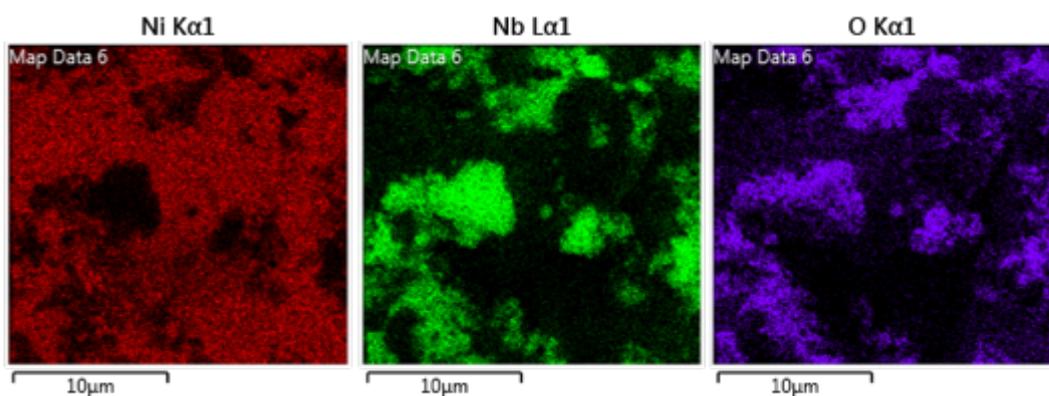
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55 Figure S1. EDS mapping of Ni|Nb₂O₅ catalyst.

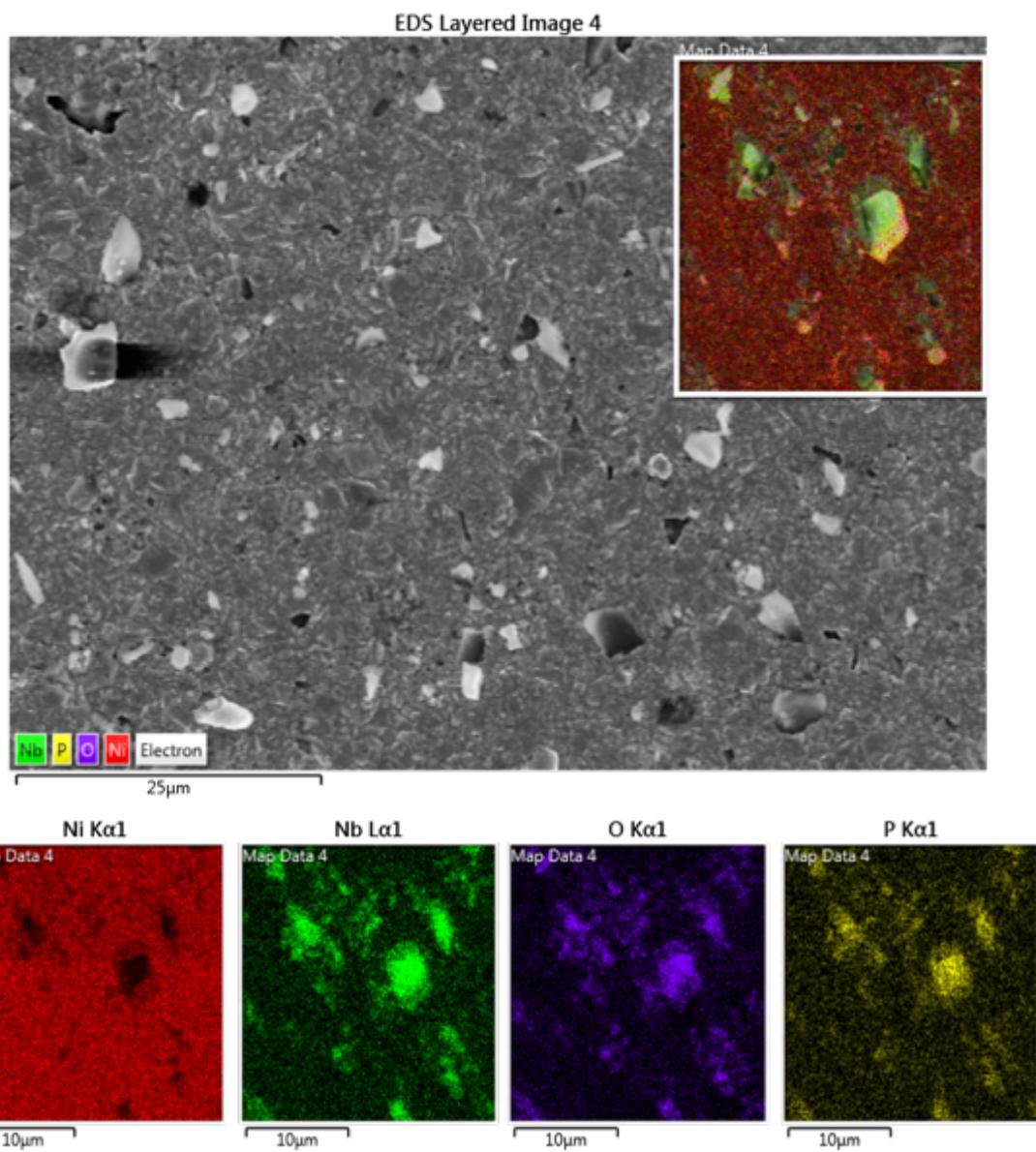


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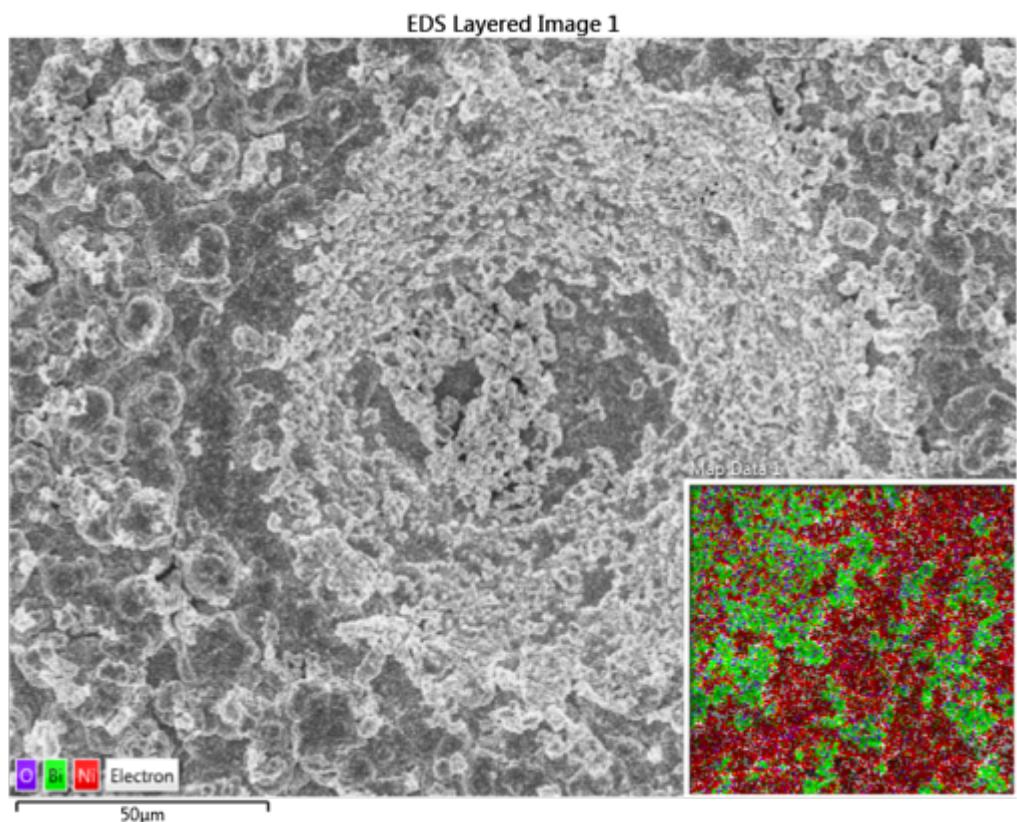


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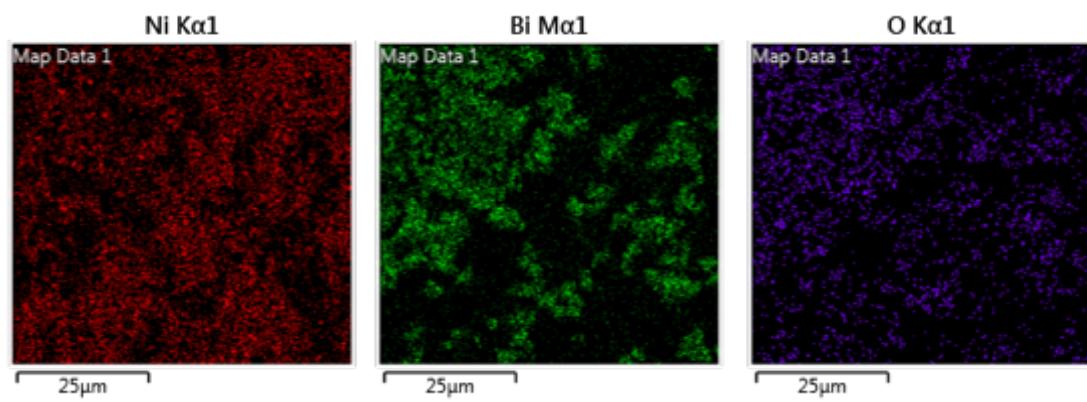
58 Figure S2. EDS mapping of Ni|Nb₃(PO₄)₅ catalyst.



61 Figure S3. EDS mapping of Ni|Bi₂O₃ catalyst.

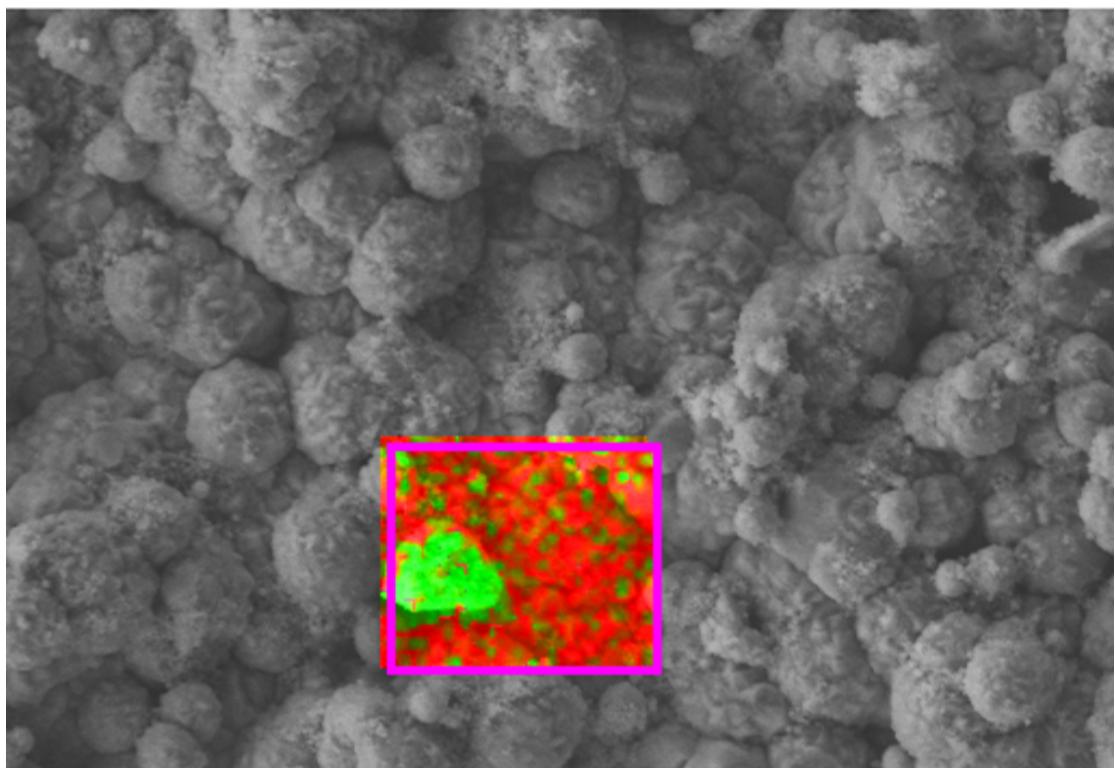


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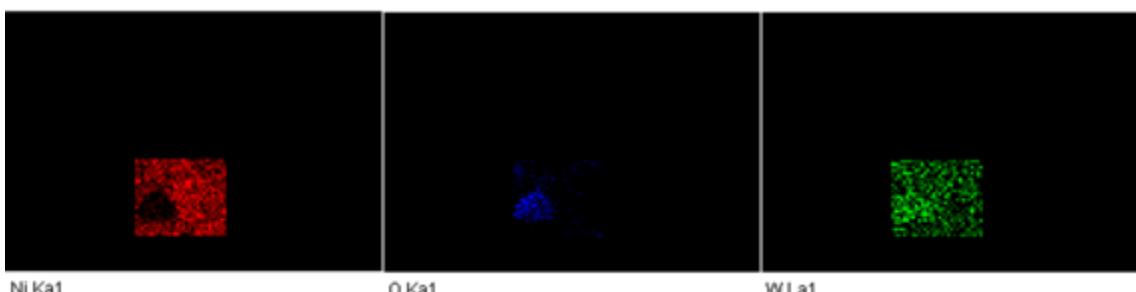


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64 Figure S4. EDS mapping of Ni|WO₃ catalyst.

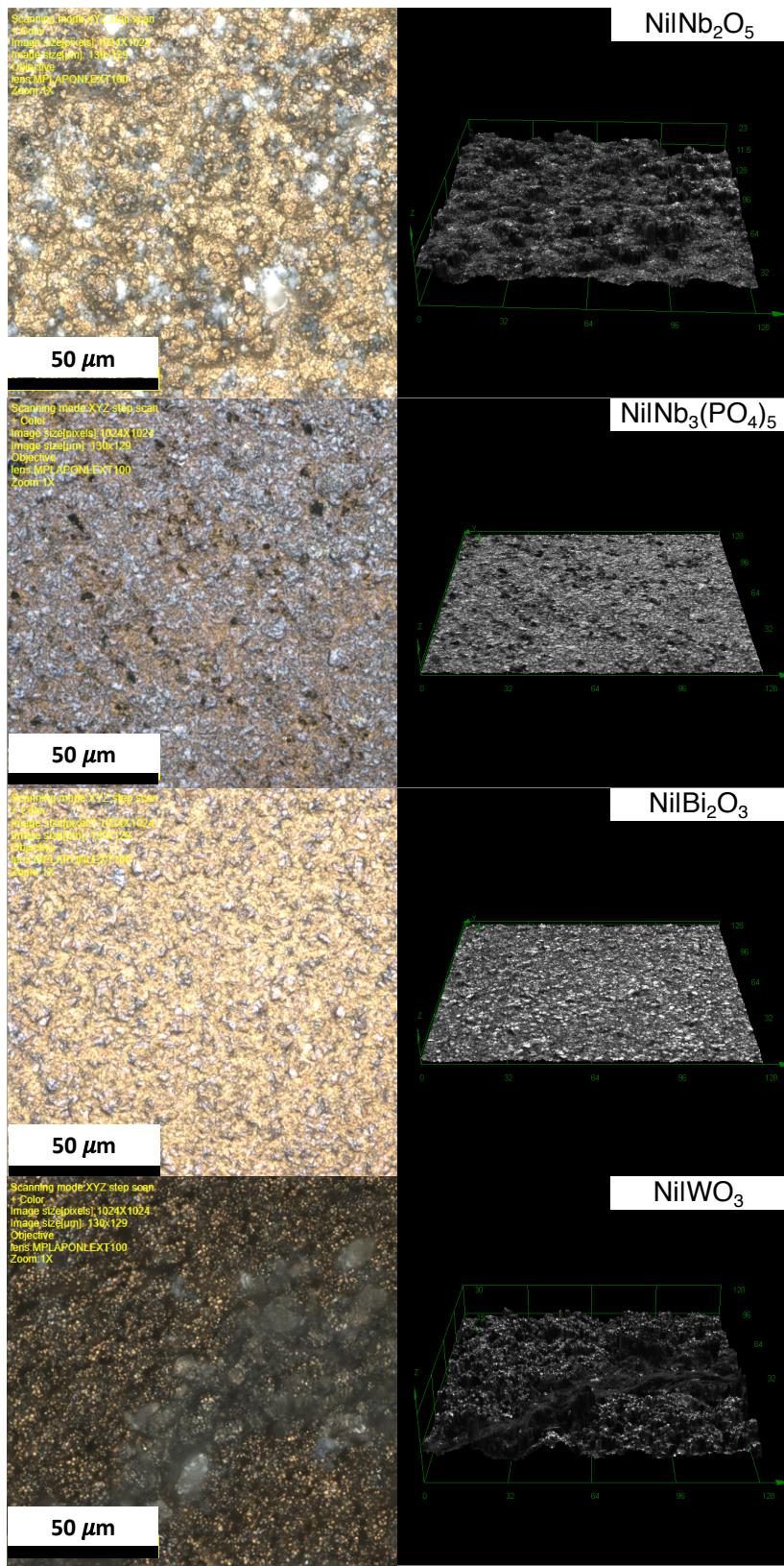


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67 Figure S5. Confocal imaging of Ni|SC electrodes after ageing process (4h at -1.5 V vs
68 SCE).

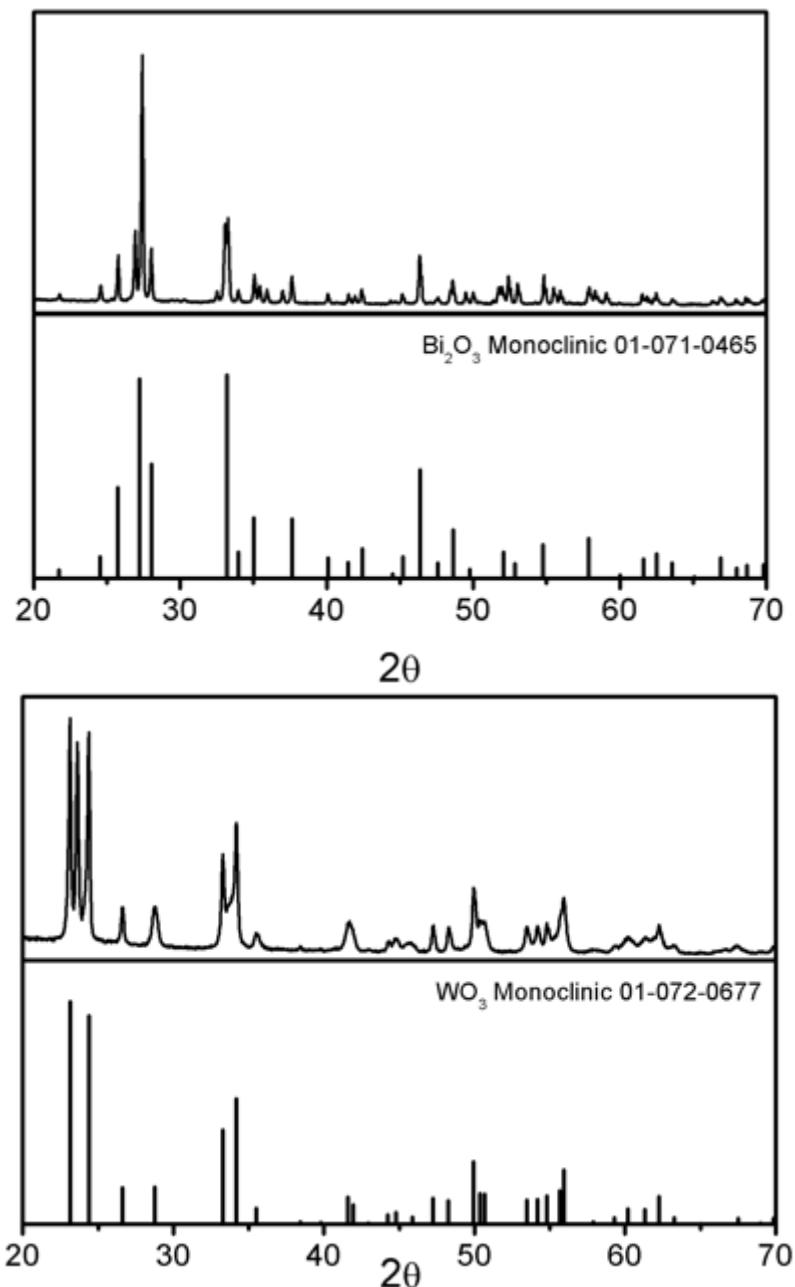


71 Table S1. Ni|SC electrodes total area calculated from confocal images in Figure S5 and
72 corresponding roughness factor.

	Total Area ^a / μm^2	R _f
Ni Nb ₂ O ₅	30,841	1.84
Ni Nb ₃ (PO ₄) ₅	20,736	1.24
Ni Bi ₂ O ₃	23,213	1.38
Ni WO ₃	29,732	1.77

73 ^a Geometric area 16,784 μm^2 .

74 Figure S6. XRD pattern from the semiconductors used. Note Nb_2O_5 orthorhombic [00-
75 027-1313] and monoclinic crystalline structure [00-016-0053] as well as the amorphous
76 nature of $\text{Nb}_3(\text{PO}_4)_5$ are described in literature^[1].



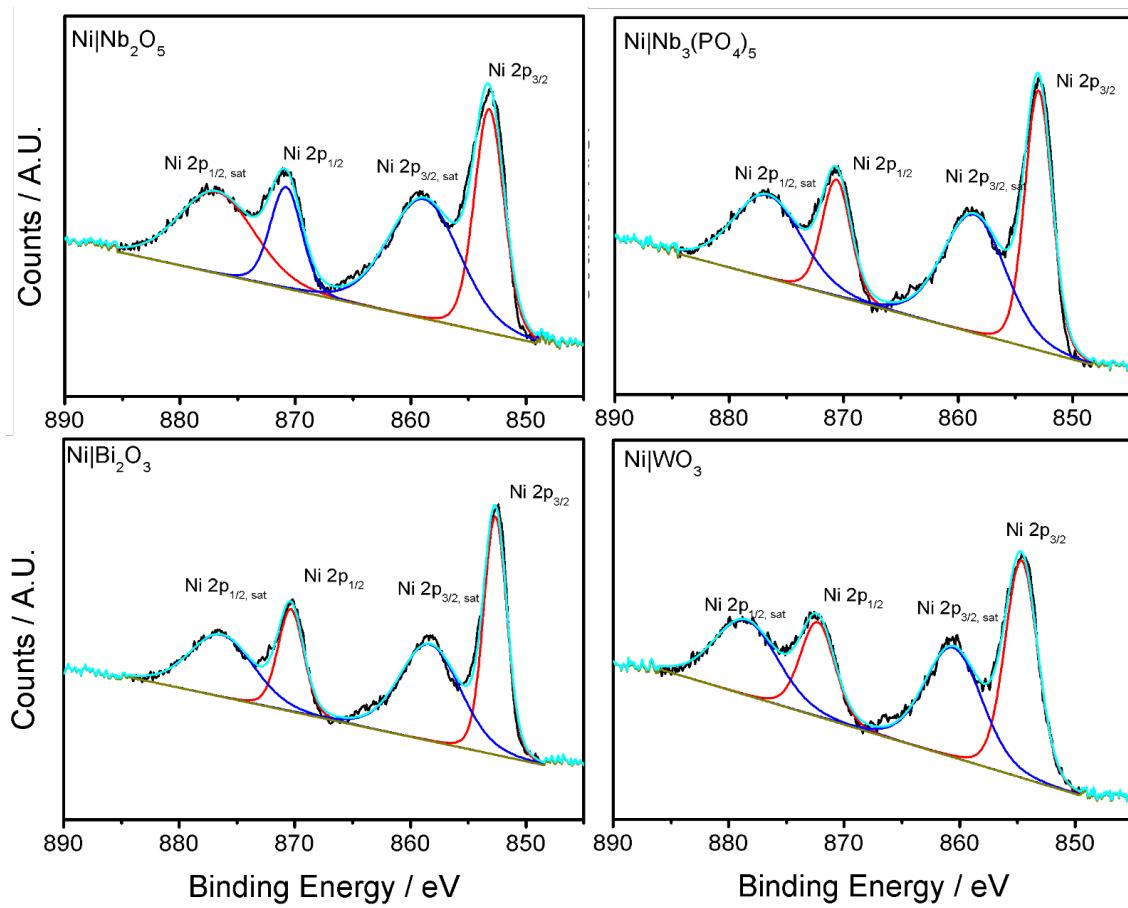
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82 Table S2. Lattice parameters calculated from XRD analysis of the SC before (SC) and
83 after electrodeposition (Ni|SC).

Plane		2θ		d spacing (Å)	
		SC	NiSC	SC	NiSC
WO ₃	001	23.12	23.16	3.84	3.84
Nb ₂ O ₅	040	22.65	22.61	3.92	3.93
Bi ₂ O ₃	120	27.42	27.38	3.25	3.26
Nb ₃ (PO ₄) ₅	---	---	---	---	----

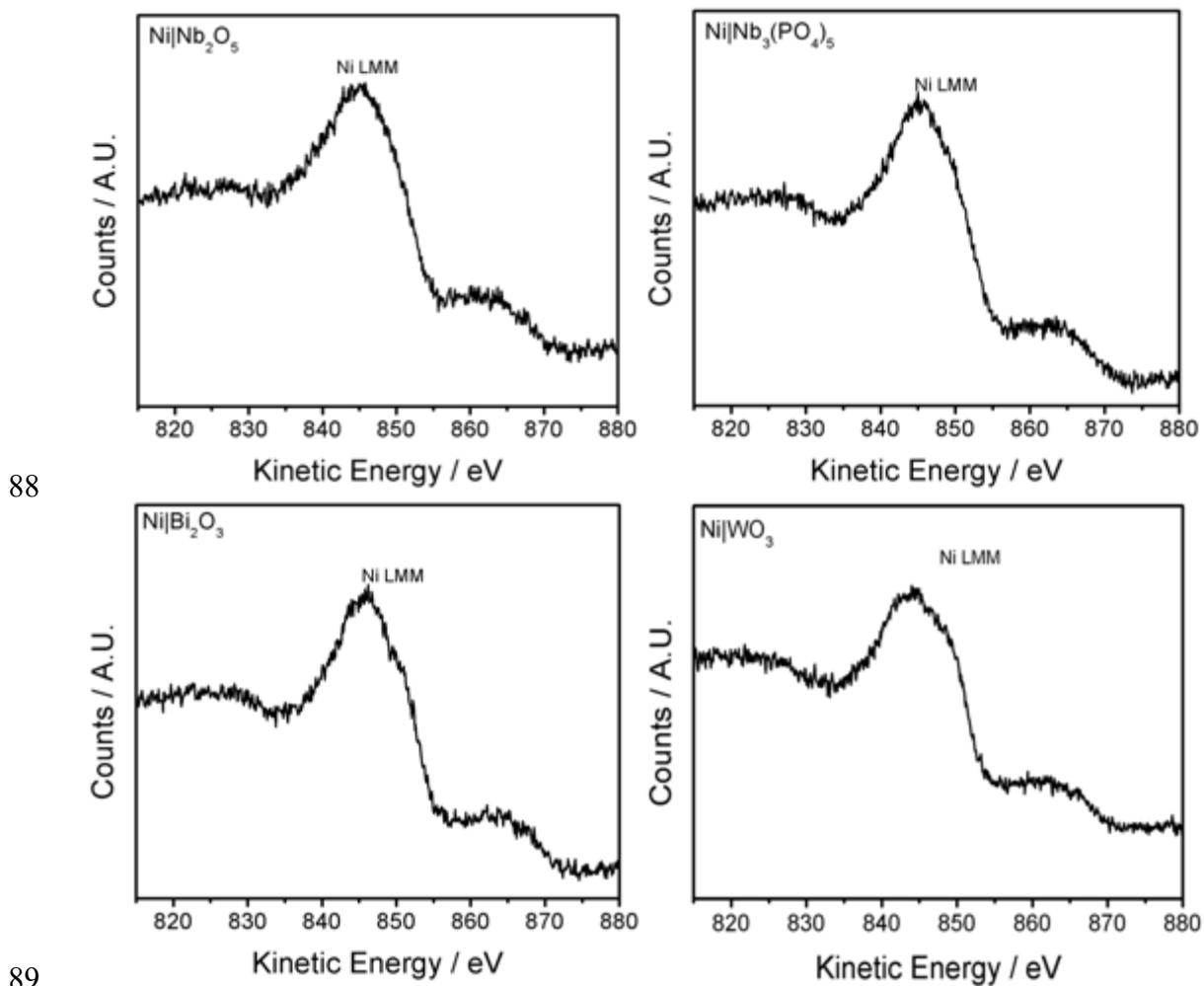
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85 Figure S7. Ni 2p XPS spectra for Ni|SC electrodes.

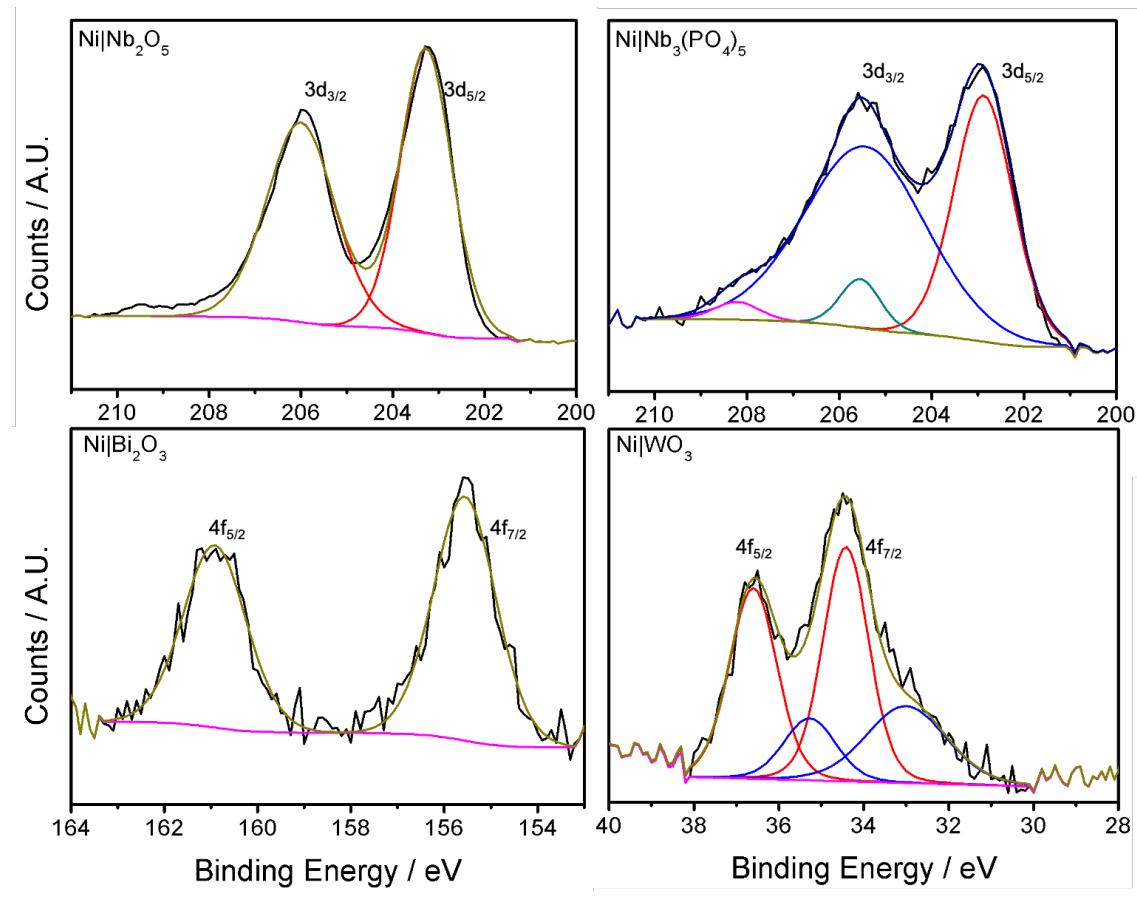


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87 Figure S8. Ni LMM Auger spectra for Ni|SC electrodes.



90 Figure S9. HR XPS spectra for Ni|SC electrodes.

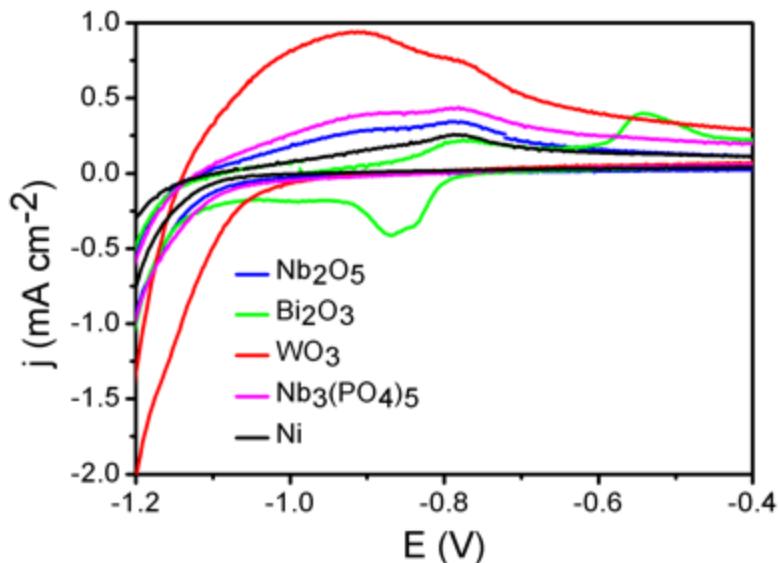


93 Table S3. XPS analysis for different Ni|SC.

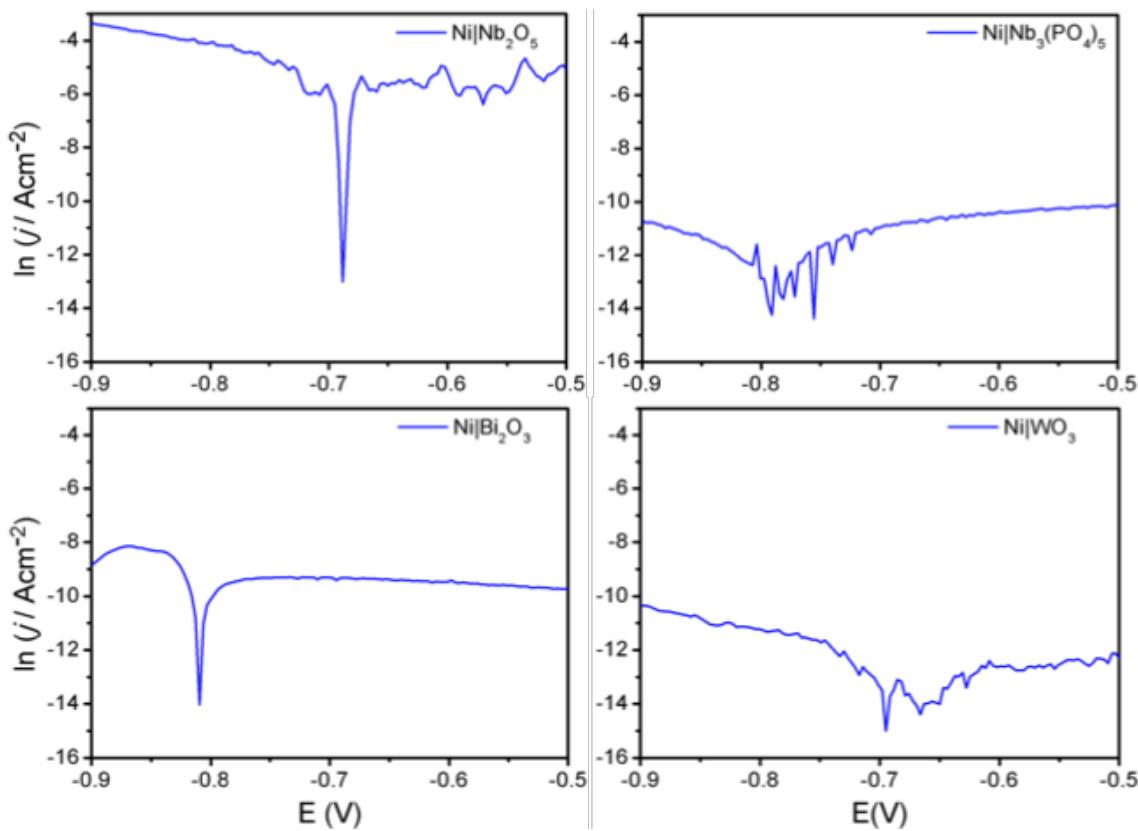
Compound	Ni 2p _{3/2} peak		Ni 2p _{1/2} peak		Δ (eV)	Auger peak KE (eV)
	BE (eV)	ΔE_B (eV)	BE (eV)	ΔE_B (eV)		
Ni	852.73 ^[2]	--	870.10 ^[2]	--	17.37	846.22 ^[3]
Ni Nb ₂ O ₅	853.20	0.47	870.81	0.71	17.61	845.79
Ni Nb ₃ (PO ₄) ₅	852.98	0.25	870.64	0.54	17.67	844.99
Ni Bi ₂ O ₃	852.66	-0.07	870.35	0.25	17.69	846.19
Ni WO ₃	854.66	1.93	872.30	2.20	17.64	844.99

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96 Figure S10. Oxidation/reduction peaks observed close to OP measured in 1.0 M KOH
97 aqueous solution and recorded at 298 K at 10 mVs^{-1} .



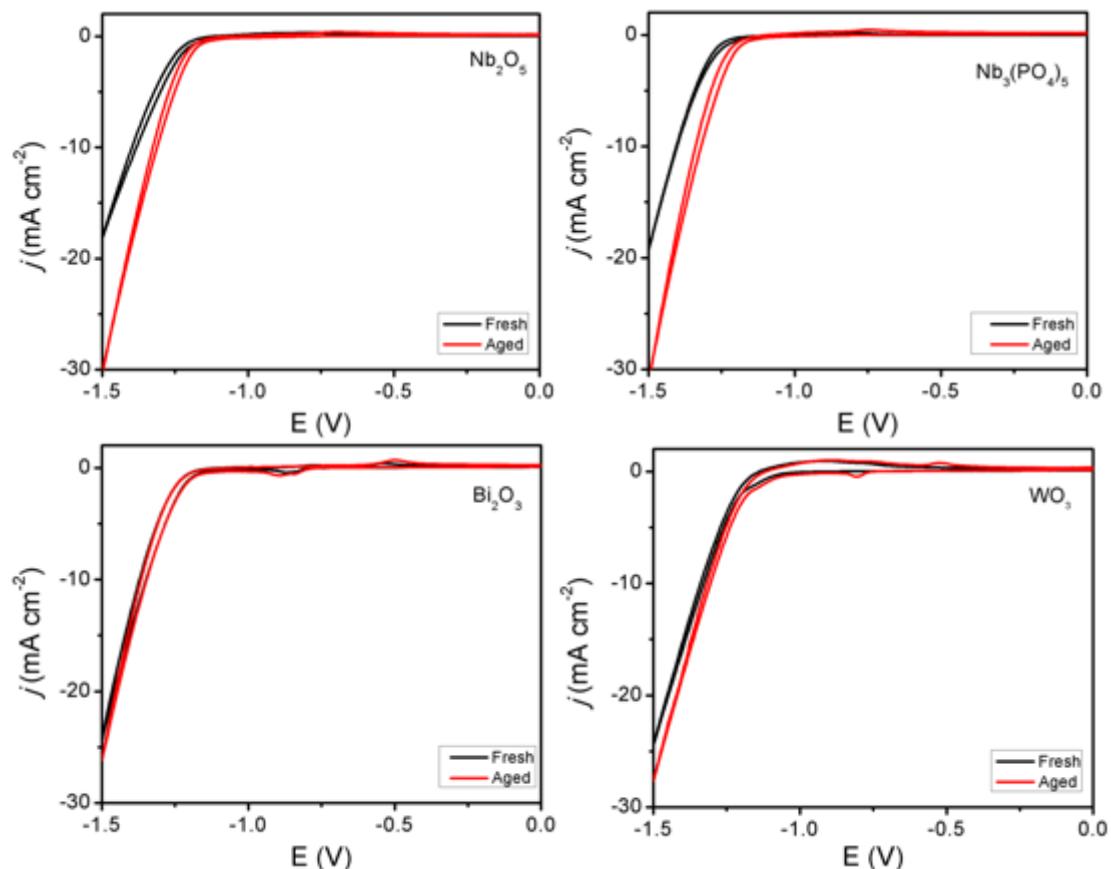
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99 Figure S11. Tafel curves constructed from cyclic voltammograms measured in 1.0 M
100 KOH aqueous solution and recorded at 298 K at 10 mVs^{-1} .



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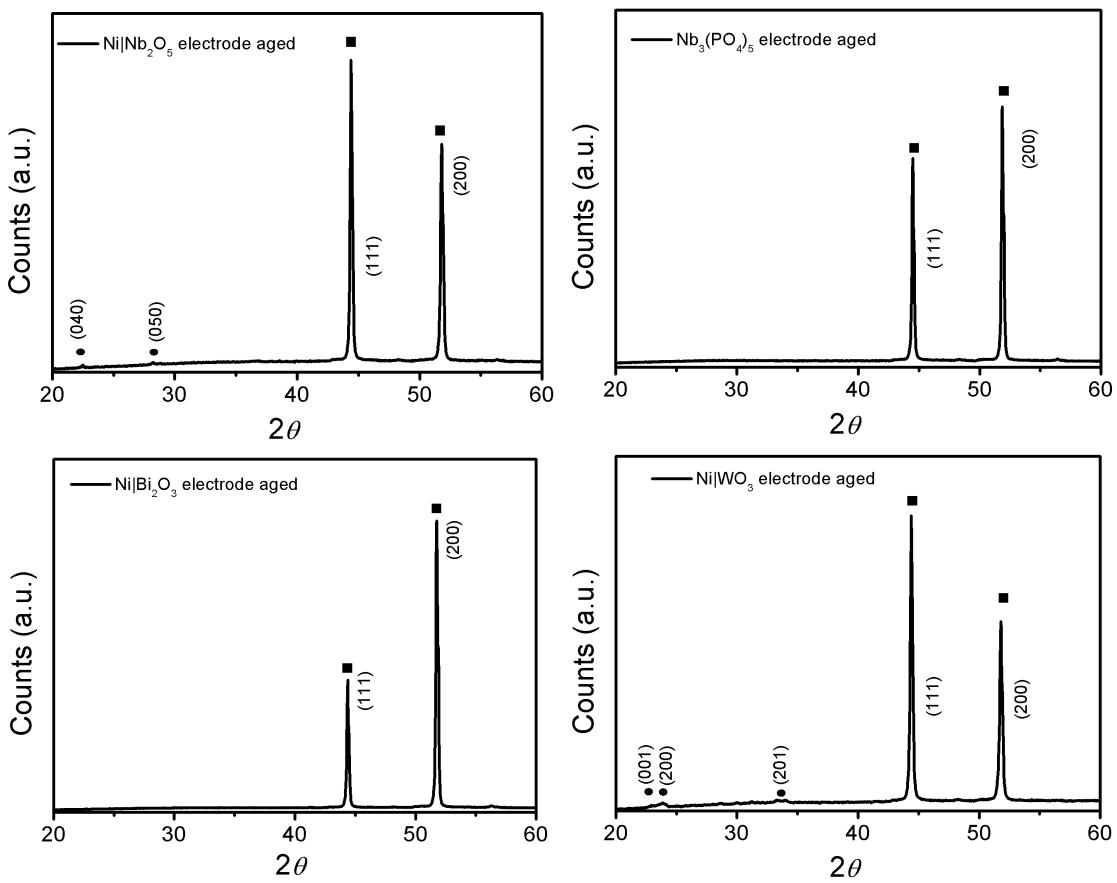
102 Figure S12. Cyclic voltammograms of freshly synthesised and aged Ni|SC catalysts
103 measured in KOH 1.0 M and recorded at 298 K and 10 mVs⁻¹.

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106 Figure S13. X-ray diffraction (XRD) pattern of Ni|SC electrodes after ageing process
107 (4h at -1.5 V vs SCE).

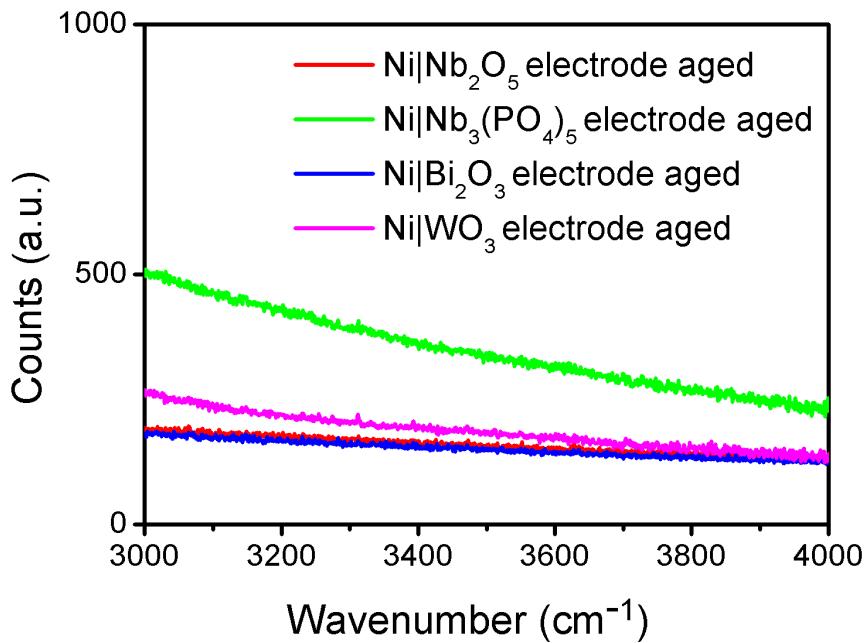


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110 Table S4. Crystallite size calculated using the Scherrer equation for fresh and aged
111 catalysts.

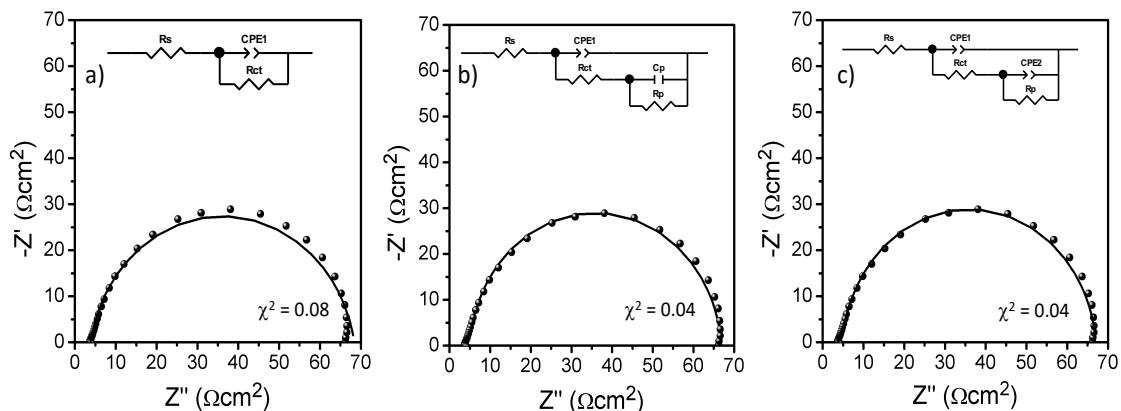
	Fresh / nm (± 1 nm)	Aged / nm (± 1 nm)	Plane
Ni Bi ₂ O ₃	40.7	42.2	(111)
	40.0	41.0	(200)
Ni Nb ₂ O ₅	42.7	44.0	(111)
	34.2	36.1	(200)
Ni Nb ₃ (PO ₄) ₅	44.8	43.9	(111)
	41.9	39.1	(200)
Ni WO ₃	40.7	38.7	(111)
	32.9	34.9	(200)

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113 Figure S14. Raman spectra of Ni|SC electrodes after ageing process showing no signals
114 detected in the region where unreactive nickel hydroxide species are expected.^[4]

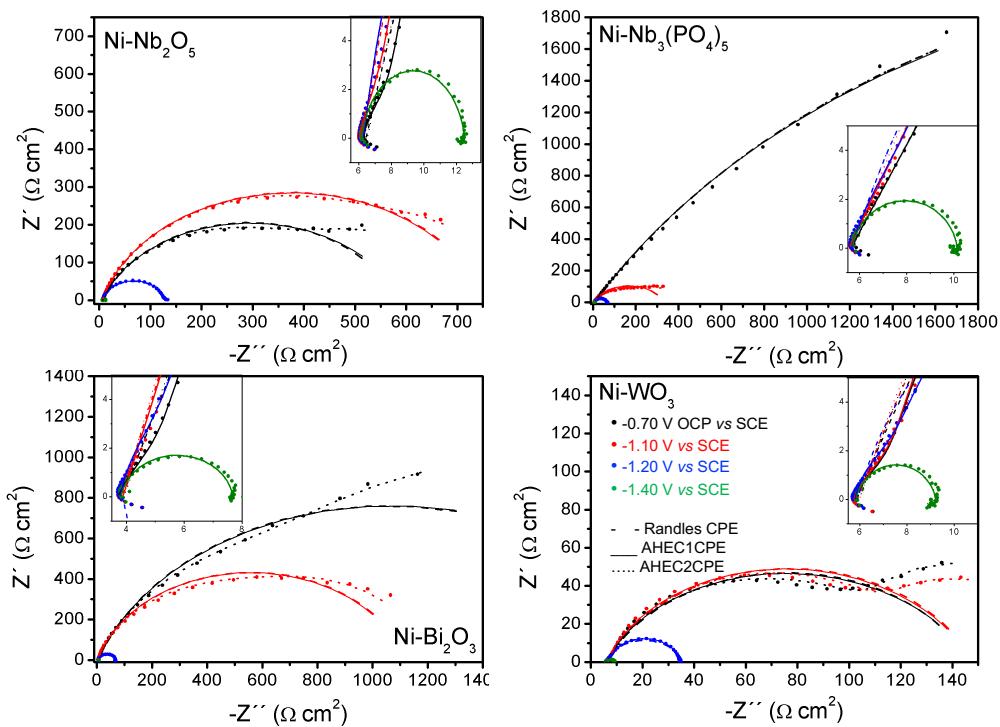


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116 Figure S15. EIS measured for Ni|Bi₂O₃ electrodes at 298 K and -1.2 V (vs SCE) fitted
117 with the equivalent circuit models: (a) Randles-CPE, (b) AHEC1CPE, (c) AHEC2CPE.



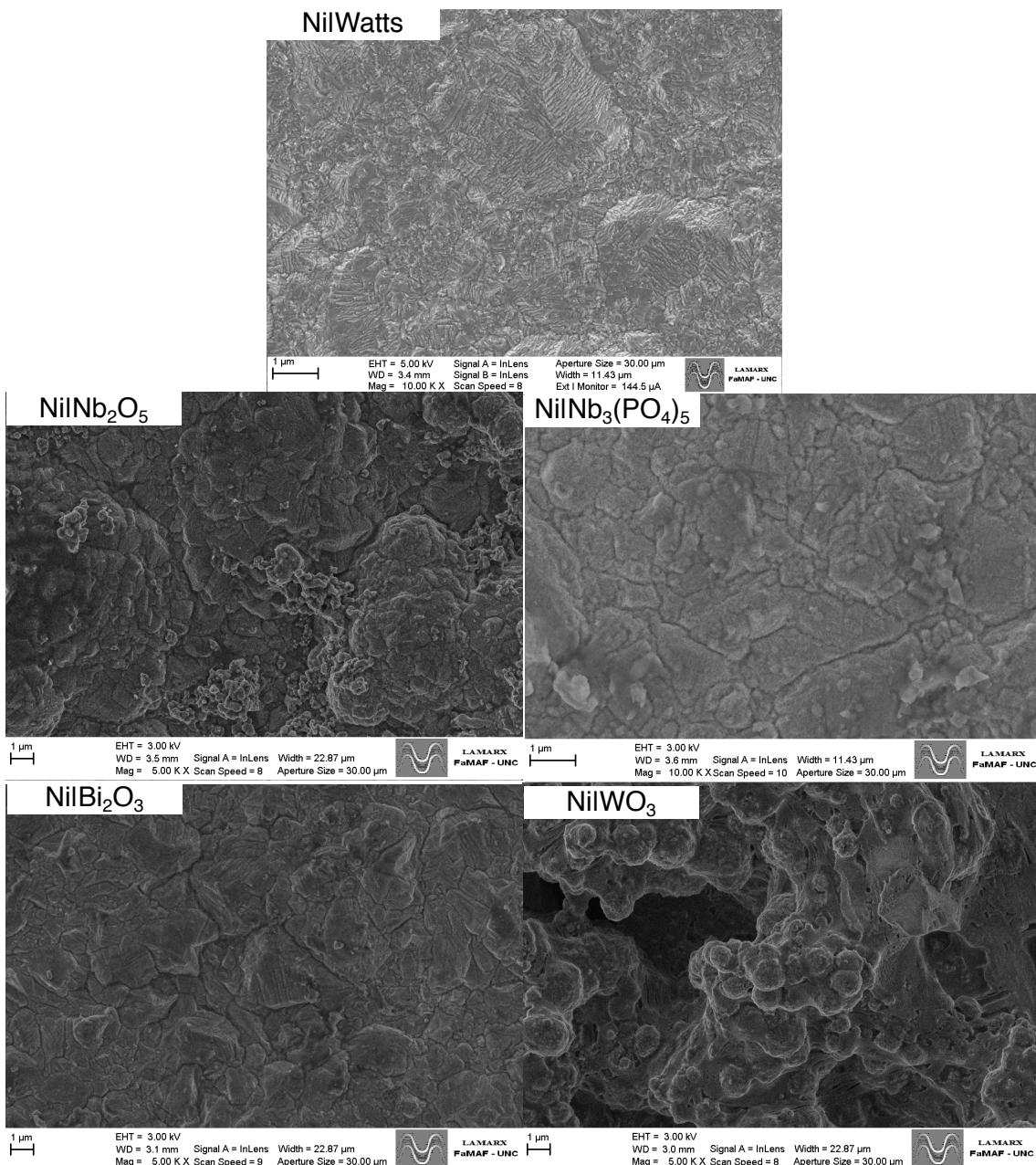
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119 From the analysis of figures like Figure S14 prepared for each catalyst (Figure S15) we
120 selected the AHEC1CPE model. The main limitation of Randles-CPE equivalent circuit
121 is that it can only be used to fit one half-circle of the Nyquist plot which is commonly
122 associated to the surface roughness^[5-6], while the AHEC2CPE presents an excellent fit
123 for two processes (increase of surface roughness and HER), although the use of a second
124 CPE in replacement of the C_p lacks of physical significance, making the model
125 inappropriate.

126 Figure S16. EIS measured for all Ni|SC electrodes at 25 °C and at different potentials
 127 fitted with the equivalent circuit models Randles-CPE, AHEC1CPE, and AHEC2CPE.

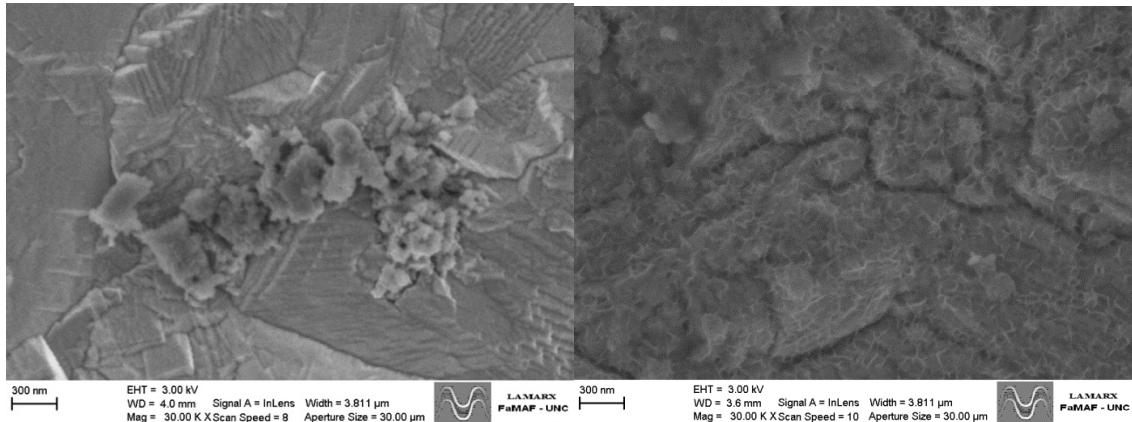


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130 Figure S17. SEM imaging of Ni|Watts and Ni|SC electrodes after ageing process (4h at -
131 1.5 V vs SCE). Scale bar: 1 μ m.



133 Figure S18. Comparison of SEM micrographs of Ni|Nb₃(PO₄)₅ before (left) and after
134 (right) ageing.



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